

MOSPEC SEMICONDUCTOR CORP.

76, CHUNG SHAN RD., HSIN SHIH, TAINAN,

TAIWAN, R. O. C.

Report No. : CE/2004/73070

Date : 2004/07/30

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The following merchandise was (were) submitted and identified by the client as :

Type of Product : ELECTRONIC SEMICONDUCTOR

Style/Item No : PLASTIC PACKAGE/TRANSISTOR, DIODE, MOSFET, THYRISTOR,

TVS DEVICE

Sample Received : 2004/07/23

Testing Date : 2004/07/23 TO 2004/07/30

Test Result

PART NAME NO.1 SILVER COLORED METAL PIN

					Result	
Test Item (s):	Umit	Method	MDL	No.1		
Chromium VI (Cr+6)		As per US EPA 7196A and US EPA 3060A.	2	N.D.		
Cadmium (Cd)		ICP-AES after as per EN 1122, method B:2001 or other acid digestion.	2	N.D.		
Mercury (Hg)		ICP-AES after as per US EPA 3052 or other acid digestion.	2	N.D.		
Lead (Pb)	-	ICP-AES after as per US EPA 3050B or other acid digestion.		N.D.		

NOTE: (1) N.D. = Not detected (<MDL)

(2) ppm = mg/kg

(3) MDL = Method Detection Limit

Signed for and on behalf of

SGS TAIWAN LTD.

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SGS Testing Korea Co., Ltd.

#18-34, Sanbon-dong, Gunpo-city, Kyunggi-do, Korea 435-040 Tel: 031) 428-5765~6, Fax: 031) 427-2374, InterNet>http://www.sgslab.co.kr

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DONG JIN SEMICHEM CO.,LTD. 472-2, Kajwa-dong, Su-gu, Inchon, Korea

The following merchandise was submitted and identified by the client as: -

Type of Product **Epoxy molding Compound**

SGS File No. G-49/2004-2359/4A

Buyer **SONY**

Style / Item No. DMC-10(L,P), 20, 200NF, 2000AS(AT,AW), 2000JCQ(L), 2100VS,

40(H,I,W), 727XL(U), 8000, EF-300, EF910, EF960

Country of Origin Korea

Sample Receiving Date Sep. 06, 2004

Test Performing Date Sep. 07, 2004

Test Performed SGS Testing Korea tested the sample which was selected by applicant with

following result.

Test Results For further details, please refer to following page.

SGS Testing Korea Co., Ltd.

ac S. / Han

Jason Han / Director

KHJ/hjp

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Heavy Metal Test

Item(s)	Unit	Test Method	DL	Result(s)	Requirements	Conclusion
Cadmium (Cd)	mg/kg	USEPA 3050B, ICP-AES	0.5	n. d.	5	Pass
Lead (Pb)	mg/kg	USEPA 3050B, ICP-AES	5	n. d.	100	Pass
Mercury (Hg)	mg/kg	USEPA 3052, ICP-AES	0.5	n. d.	-	-
Hexavalent Chromium (Cr VI)	mg/kg	USEPA 3060A, UV-Vis	0.16	n. d.	-	-

Flame Retardants

Items		Test Method	D.L.	Results
Polybrominated Biphenyls (PBBs)		-	-	-
Bromobiphenyl	mg/kg		5	n. d.
Dibromobiphenyl	mg/kg		5	n. d.
Tribromobiphenyl	mg/kg		5	n. d.
Tetrabromobiphenyl	mg/kg	With reference to 83/264/EEC	5	n. d.
Pentabromobiphenyl	mg/kg	and 2003/11/EEC. Analysis was performed by	5	n. d.
Hexabromobiphenyl	mg/kg	GC/MS.	5	n. d.
Heptabromobiphenyl	mg/kg		5	n. d.
Octabromobiphenyl	mg/kg		5	n. d.
Decabromobiphenyl	mg/kg		5	n. d.
Polybrominated Diphenyl Ethers (PBDEs)	-	-	-	-
Bromodiphenyl ether	mg/kg		5	n. d.
Dibromodiphenyl ether	mg/kg		5	n. d.
Tribromodiphenyl ether	mg/kg		5	n. d.
Tetrabromodiphenyl ether	mg/kg	With reference to 83/264/EEC and 2003/11/EEC.	5	n. d.
Pentabromodiphenyl ether	mg/kg		5	n. d.
Hexabromodiphenyl ether	mg/kg	Analysis was performed by	5	n. d.
Heptabromodiphenyl ether	mg/kg	GC/MS.	5	n. d.
Octabromodiphenyl ether	mg/kg		5	n. d.
Nonabromodiphenyl ether	mg/kg		5	n. d.
Decabromodiphenyl ether	mg/kg		5	n. d.

Note: $n. d. = Not de$	tected		
*******	*******	End	***********

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